

IRLB3036PBF-VB Datasheet N-Channel 60 V (D-S) MOSFET

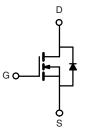
PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)} (\Omega)$ at $V_{GS} = 10 V$	0.0016			
$R_{DS(on)}$ (Ω) at V_{GS} = 4.5 V	0.0020			
I _D (A)	270			
Configuration	Single			

FEATURES

- Trench power MOSFET
- Package with low thermal resistance
- 100 % $\rm R_g$ and UIS tested







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C =$	25 °C, unles	ss otherwise noted)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	60	V
Gate-Source Voltage		V _{GS}	± 20	v
Continuous Drain Current	T _C = 25 °C	- I _D	270	
	T _C = 125 °C		120 ^a	
Continuous Source Current (Diode Conduction)		I _S	120 ^a	А
Pulsed Drain Current ^b		I _{DM}	600	
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	75	
Single Pulse Avalanche Energy		E _{AS}	281	mJ
Maximum Power Dissipation ^b	T _C = 25 °C	P _D	375	W
	T _C = 125 °C		125	٧V
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient P	CB Mount c	R _{thJA}	40	°C/W
Junction-to-Case (Drain)		R _{thJC}	0.4	0/10

Notes

a. Package limited.

b. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

c. When mounted on 1" square PCB (FR4 material).



SPECIFICATIONS ($T_C = 25 \ ^{\circ}C$,		vise noted)		F	r	r	
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	60	-	-	v
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	1.5	2.0	2.5	v
Gate-Source Leakage	I _{GSS}	V _{DS} =	0 V, V_{GS} = ± 20 V	-	-	± 100	nA
		$V_{GS} = 0 V$	V _{DS} = 60 V	-	-	1	μA
ero Gate Voltage Drain Current In-State Drain Current ^a Irain-Source On-State Resistance ^a orward Transconductance ^b Input Capacitance	I _{DSS}	$V_{GS} = 0 V$	$V_{DS}=60~V,~T_J=125~^\circ C$	-	-	50	μΛ
		$V_{GS} = 0 V$	V_{DS} = 60 V, T_J = 175 °C	-	-	1.5	mA
On-State Drain Current ^a	I _{D(on)}	$V_{GS} = 10 V$	$V_{DS} \ge 5 V$	120	-	-	А
	stance ^a R _{DS(on)}	$V_{GS} = 10 \text{ V}$	I _D = 30 A	-	0.0016	-	Ω
Drain-Source On-State Resistance a		$V_{GS} = 10 V$	$I_D = 30 \text{ A}, \text{ T}_J = 125 \ ^\circ\text{C}$	-	0.0031	-	
Drain-Source On-State Resistance a		$V_{GS} = 10 V$	$I_D = 30 \text{ A}, \text{T}_\text{J} = 175 \ ^\circ\text{C}$	-	0.0037	-	
		$V_{GS} = 4.5 V$	I _D = 20 A	-	0.0020	-	1
Forward Transconductance ^b	9 _{fs}	V _{DS}	= 15 V, I _D = 30 A	-	164	-	S
Dynamic ^b					-		
Input Capacitance	C _{iss}			-	12 060	15 100	
Output Capacitance	C _{oss}	$V_{GS} = 0 V$	V _{DS} = 25 V, f = 1 MHz	-	5750	7200	pF
Reverse Transfer Capacitance	C _{rss}			-	860	1100	
Total Gate Charge ^c	Qg			-	128	200	
Gate-Source Charge ^c	Q _{gs}	V _{GS} = 10 V	$V_{DS} = 30 \text{ V}, I_{D} = 80 \text{ A}$	-	33	- 2.5 ± 100 1 50 1.5 - 5 - 1 - 0 - 0 15 100 7200 1100 200 1100 200 - - 2.6 25 40	nC
Gate-Drain Charge ^c	Q _{gd}			-	11	-	
Gate Resistance	Rg		f = 1 MHz	0.8	1.68	2.6	Ω
Turn-On Delay Time ^c	t _{d(on)}			-	20	25	
Rise Time ^c	t _r	$V_{DD} = 30 \text{ V}, \text{ R}_{\text{L}} = 0.375 \ \Omega$ $\text{I}_{\text{D}} \cong 80 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \ \Omega$		-	15	40	- ns
Turn-Off Delay Time ^c	t _{d(off)}			-	65	100	
Fall Time ^c	t _f			-	12	20	
Source-Drain Diode Ratings and Chara	acteristics ^b	•			•		
Pulsed Current ^a	I _{SM}			-	-	300	Α
Forward Voltage	V _{SD}	I _F =	80 A, V _{GS} = 0 V	-	0.88	1.5	V

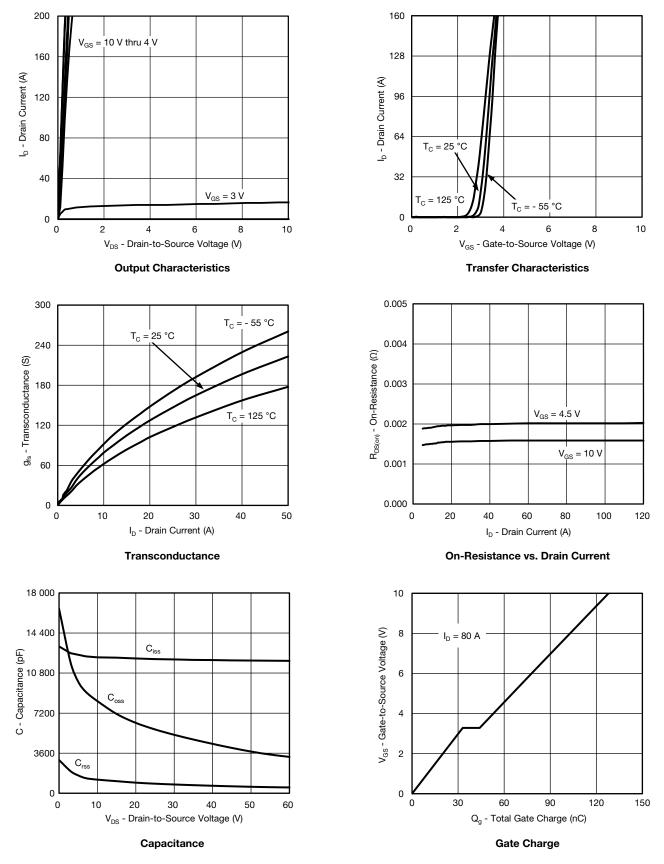
Notes

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.



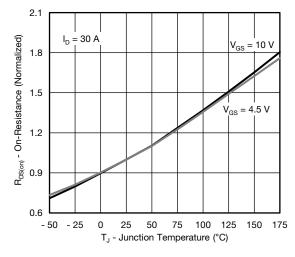
TYPICAL CHARACTERISTICS ($T_A = 25 \text{ °C}$, unless otherwise noted)



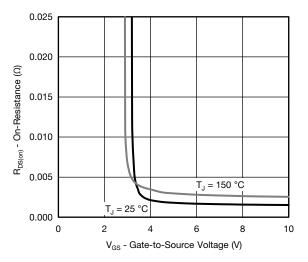
服务热线:400-655-8788



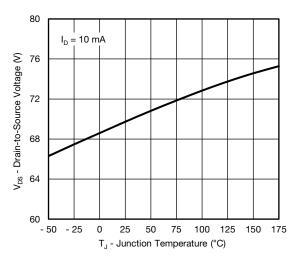
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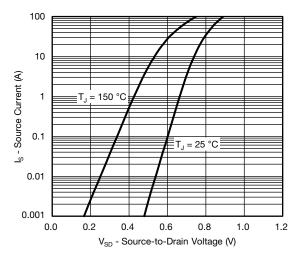
On-Resistance vs. Junction Temperature



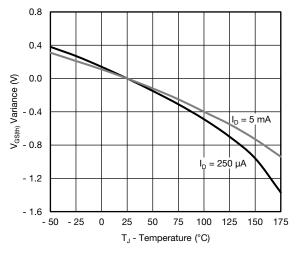
On-Resistance vs. Gate-to-Source Voltage



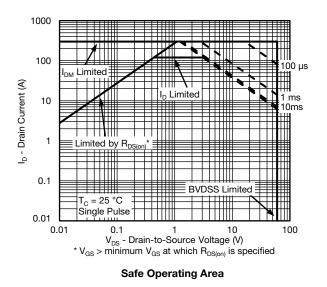
Drain Source Breakdown vs. Junction Temperature



Source Drain Diode Forward Voltage

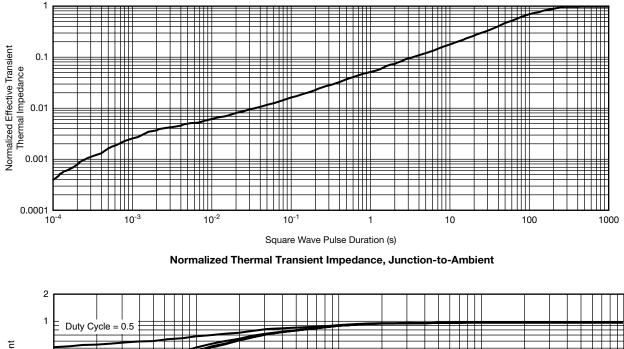


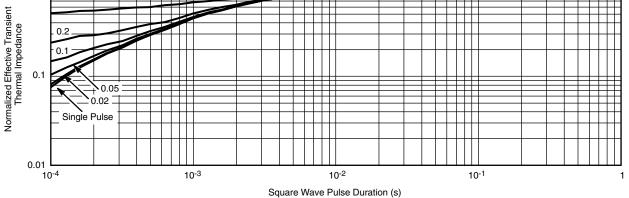


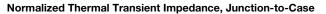




THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)







Note

• The characteristics shown in the two graphs

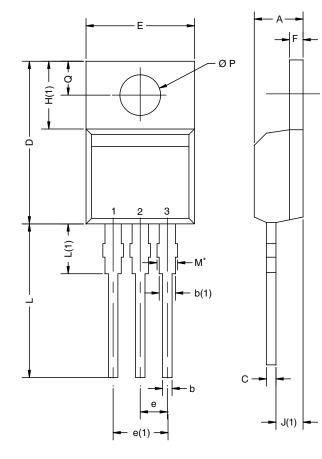
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-220AB



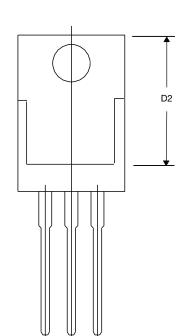
		INCHES		MILLIMETERS		
DIM.		MIN.	MAX.	MIN.	MAX.	
А		0.160	0.190	4.064	4.826	
	b	0.020	0.039	0.508	0.990	
	b1	0.020	0.035	0.508	0.889	
	b2	0.045	0.055	1.143	1.397	
c*	Thin lead	0.013	0.018	0.330	0.457	
С	Thick lead	0.023	0.028	0.584	0.711	
	Thin lead	0.013	0.017	0.330	0.431	
c1	Thick lead	0.023	0.027	0.584	0.685	
	c2	0.045	0.055	1.143	1.397	
	D	0.340	0.380	8.636	9.652	
	D1	0.220	0.240	5.588	6.096	
	D2	0.038	0.042	0.965	1.067	
	D3	0.045	0.055	1.143	1.397	
	D4	0.044	0.052	1.118	1.321	
	E	0.380	0.410	9.652	10.414	
	E1	0.245	-	6.223 -		
	E2	0.355	0.375	9.017 9.52		
E3		0.072	0.078	1.829	1.981	
	е	0.100 BSC		2.54 BSC		
K		0.045	0.055	1.143	1.397	
	L	0.575	0.625	14.605	15.875	
L1		0.090	0.110	2.286	2.794	
L2		0.040	0.055	1.016	1.397	
L3		0.050	0.070	1.270	1.778	
	L4	0.010 BSC		0.254 BSC		
М		-	0.002	-	0.050	

DWG: 5843

Notes

- 1. Plane B includes maximum features of heat sink tab and plastic.
- 2. No more than 25 % of L1 can fall above seating plane by max. 8 mils.
- 3. Pin-to-pin coplanarity max. 4 mils.
- 4. *: Thin lead is for SUB, SYB.
 - Thick lead is for SUM, SYM, SQM.
- 5. Use inches as the primary measurement.

A This feature is for thick lead.





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